Application/Control No. Applicant(s)/Patent Under Reexamination 10/652,202 YANAGIDA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Benjamin C. Lee 2632 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code MM-YYYY Classification US-6,842,108 01-2005 Akiyama et al. 340/310.11 US-5,031,082 В 07-1991 Bierend, Gary D. 362/233 С US-6,229,434 05-2001 Knapp et al. 340/310.16 D US-5,142,278 08-1992 Moallemi et al. 340/436 E US-US-F US-G US-Н US-1 US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Country MM-YYYY Name Classification Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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